## Applicant(s)/Patent Under Reexamination Application/Control No. 10/015,421 TATHGUR ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Philip H Leung 3742 **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-3,723,212	03-1973	Casper	219/769
	В	US-4,334,354	06-1982	Luft et al.	29/840
	ပ	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	4-7124	01-1992	Japan	Tsuchida	
	0					
	Ρ					
	Q					"
	R				·	
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.